

General Description

The WSD4090DN56 is the highest performance trench N-Channel MOSFET with extreme high cell density, which provide excellent $R_{DS(ON)}$ and gate charge for most of the synchronous buck converter applications.

The WSD4090DN56 meet the RoHS and Green Product requirement, 100% E_{AS} guaranteed with full function reliability approved.

Features

- 100% UIS + R_g Tested.
- Reliable and Rugged
- Lead Free and Green Devices Available (RoHS Compliant)
- Moisture Sensitivity Level MSL1 (per JEDEC J-STD-020D)

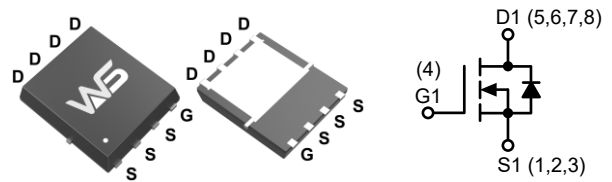
Product Summary

BV_{DSS}	$R_{DS(ON)}$	I_D
40V	4.0m Ω	90A

Applications

- Brushed motor drive applications.
- BLDC motor drive applications.
- Battery powered circuits.
- Load Switch.
- Synchronous rectifier applications.

DFN5X6-8L Pin Configuration



Absolute Maximum Ratings ($T_A=25^\circ\text{C}$, Unless Otherwise Noted)

Symbol	Parameter	Rating	Units
V_{DS}	Drain-Source Voltage	40	V
V_{GS}	Gate-Source Voltage	± 20	
I_D	Continuous Drain Current	$T_C=25^\circ\text{C}$	90
		$T_C=100^\circ\text{C}$	36
I_{DM}^2	Pulse Drain Current	$T_C=25^\circ\text{C}$	150
P_D	Maximum Power Dissipation	$T_C=25^\circ\text{C}$	65
		$T_C=100^\circ\text{C}$	33
E_{AS}^4	Avalanche Energy, Single pulse	$L=0.1\text{mH}$	56
I_{AS}^4	Avalanche Current, Single pulse	$L=0.1\text{mH}$	34
T_{STG}	Storage Temperature Range	-55 to 150	$^\circ\text{C}$
T_J	Operating Junction Temperature Range	150	
$R_{\theta JA}^3$	Thermal Resistance-Junction to Ambient	$t \leq 10\text{s}$	22
		Steady State	55
$R_{\theta JC}$	Thermal Resistance-Junction to Case	2.3	$^\circ\text{C/W}$

Electrical Characteristics ($T_J=25^{\circ}\text{C}$, Unless Otherwise Noted)

Symbol	Parameter	Conditions	Min.	Typ.	Max.	Units
BV_{DSS}	Drain-Source Breakdown Voltage	$V_{GS}=0V, I_D=250\mu A$	40	---	---	V
$R_{DS(ON)}^5$	Static Drain-Source On-Resistance	$V_{GS}=10V, I_D=20A$	---	4.0	5.0	m Ω
		$T_J=125^{\circ}\text{C}$	---	5.9	---	
$V_{GS(th)}$	Gate Threshold Voltage	$V_{GS}=V_{DS}, I_D=250\mu A$	2.0	3.0	4.0	V
I_{DSS}	Zero Gate Voltage Drain Current	$V_{DS}=32V, V_{GS}=0V$	---	---	1.0	μA
		$T_J=85^{\circ}\text{C}$	---	---	30	
I_{GSS}	Gate-Source Leakage Current	$V_{GS}=\pm 20V, V_{DS}=0V$	---	---	± 100	nA
g_{fs}	Forward Transconductance	$V_{DS}=5V, I_D=20A$	---	24	---	S
R_G^6	Gate Resistance	$V_{DS}=0V, V_{GS}=0V, f=1.0\text{MHz}$	---	0.6	---	Ω
Q_g^6	Total Gate Charge	$V_{DS}=20V, V_{GS}=10V, I_D=20A$	---	21	29	nC
Q_{gth}^6	Threshold Gate Charge		---	2.4	---	
Q_{gs}^6	Gate-Source Charge		---	6.3	---	
Q_{gd}^6	Gate-Drain Charge		---	4.0	---	
$T_{d(on)}^6$	Turn-On Delay Time	$V_{DD}=20V, R_L=20\Omega, I_{DS}=1A,$ $V_{GEN}=10V, R_G=6\Omega$	---	16	29	ns
T_r^6	Rise Time		---	9	17	
$T_{d(off)}^6$	Turn-Off Delay Time		---	26	47	
T_f^6	Fall Time		---	29	53	
C_{iss}^6	Input Capacitance	$V_{DS}=20V, V_{GS}=0V, f=1.0\text{MHz}$	---	1492	1940	pF
C_{oss}^6	Output Capacitance		---	391	---	
C_{rss}^6	Reverse Transfer Capacitance		---	49	---	

Diode Characteristics

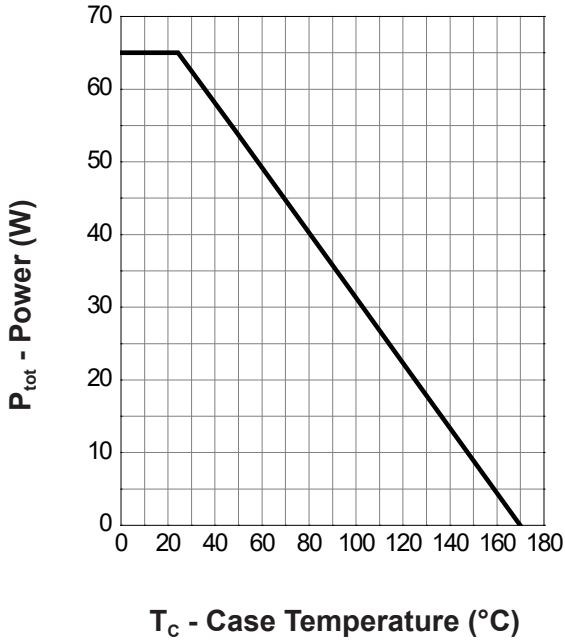
Symbol	Parameter	Conditions	Min.	Typ.	Max.	Units
I_S	Continuous Source Current	$T_C=25^{\circ}\text{C}$	---	---	50	A
V_{SD}^5	Diode Forward Voltage	$V_{GS}=0V, I_{SD}=25A$	---	0.85	1.1	V
t_{rr}	Reverse Recovery Time	$I_{SD}=20A, di_{SD}/dt=100A/\mu s$	---	15	---	ns
Q_{rr}	Reverse Recovery Charge		---	15	---	nC

Note:

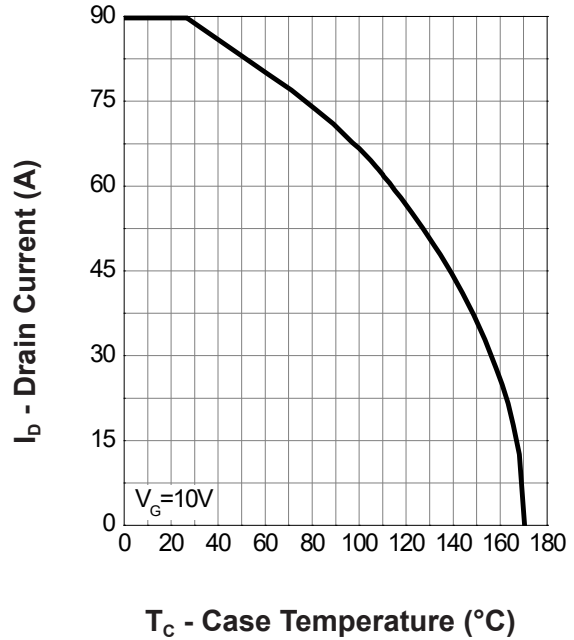
1. Maximum continuous current is limited by bonding wire.
2. Pulse width limited by maximum junction temperature.
3. Surface mounted on 1in² pad area, steady state $t=999s$.
4. UIS tested and pulse width limited by maximum junction temperature (initial temperature $T_J=25^{\circ}\text{C}$).
5. Pulse test; pulse width $\leq 300\mu s$, duty cycles $\leq 2\%$.
6. Guaranteed by design, not subject to production testing.

Typical Characteristics

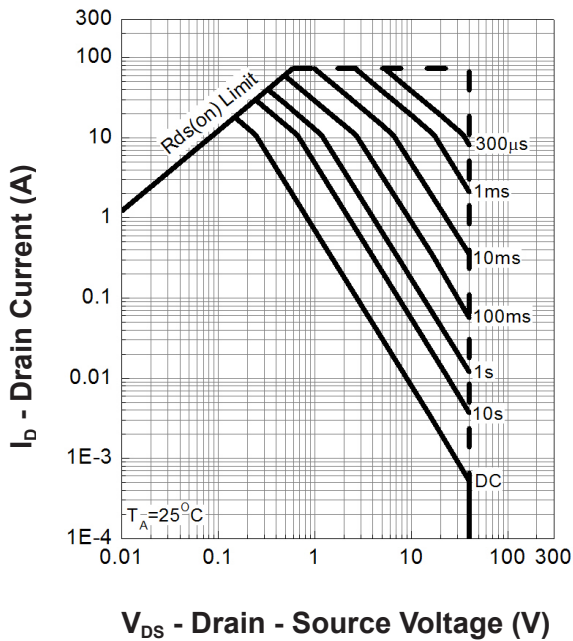
Power Dissipation



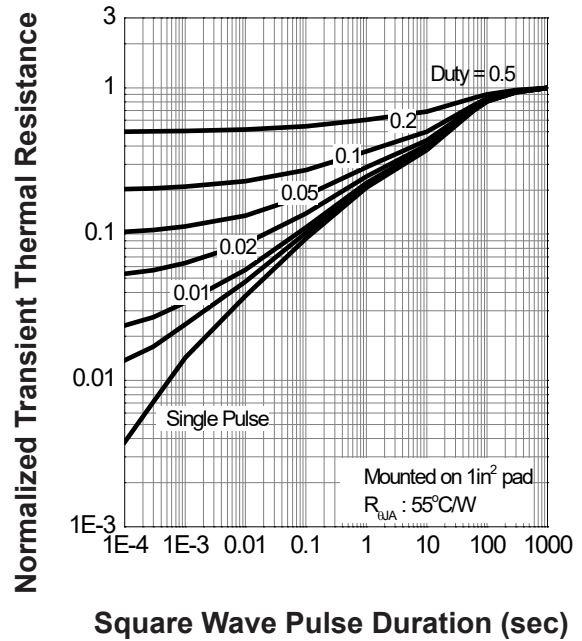
Drain Current



Safe Operation Area

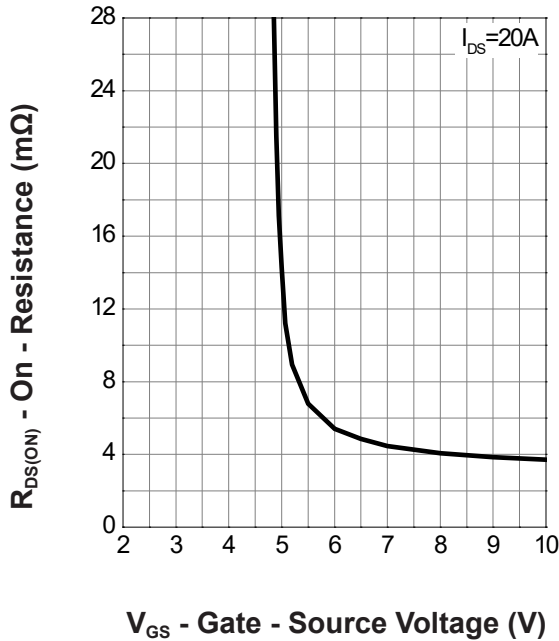


Thermal Transient Impedance

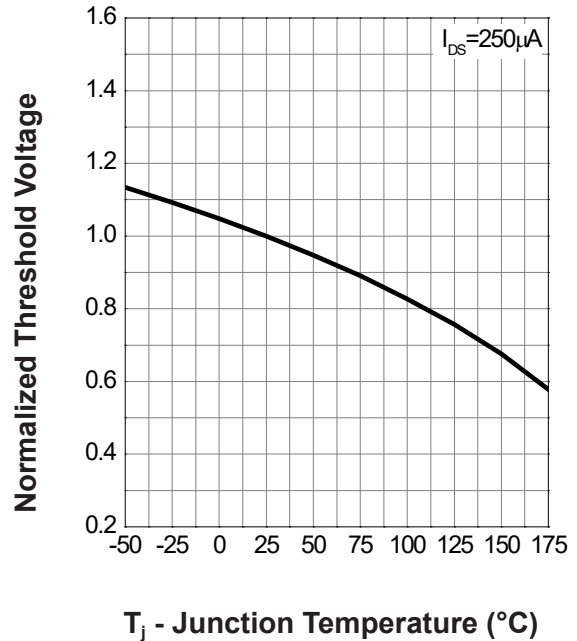


Typical Characteristics (Cont.)

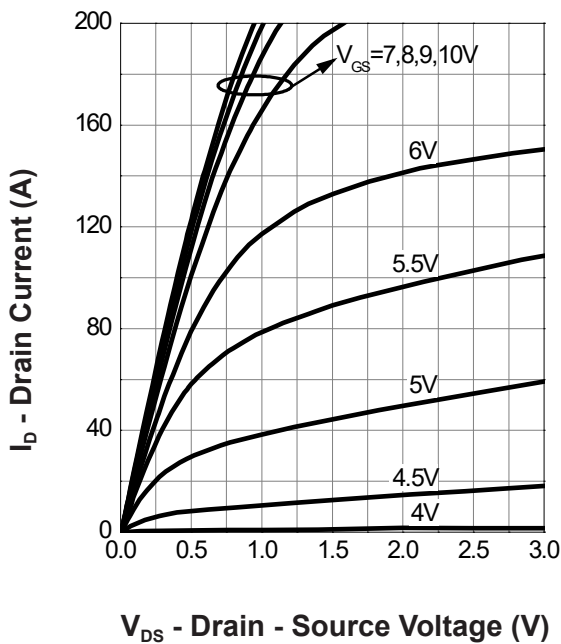
Gate-Source On Resistance



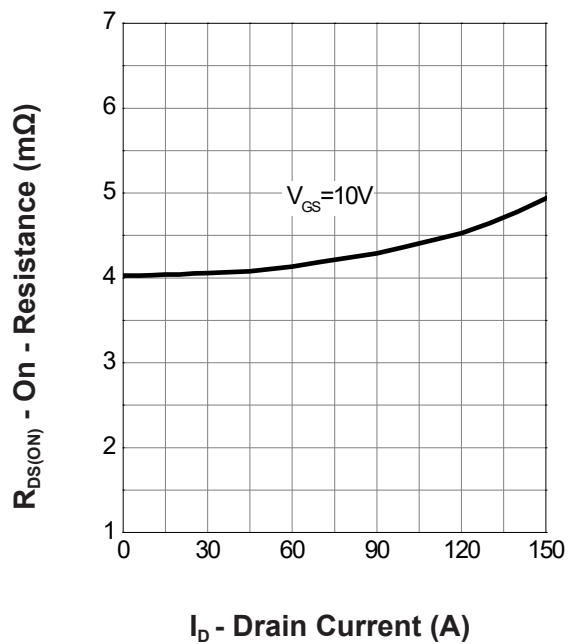
Gate Threshold Voltage



Output Characteristics

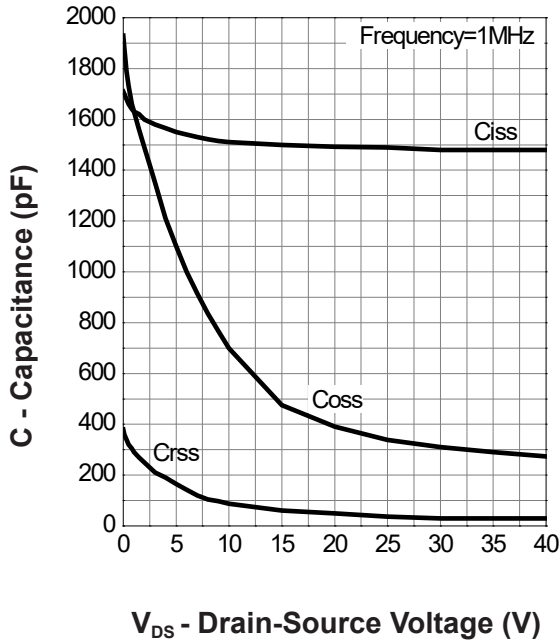


Drain-Source On Resistance

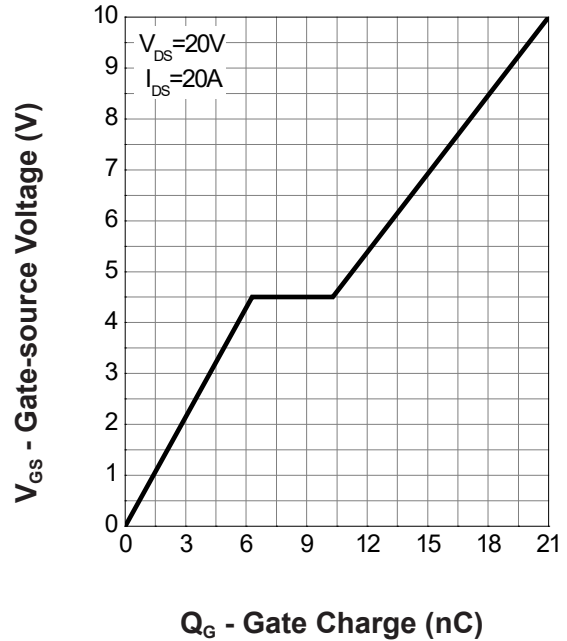


Typical Characteristics (Cont.)

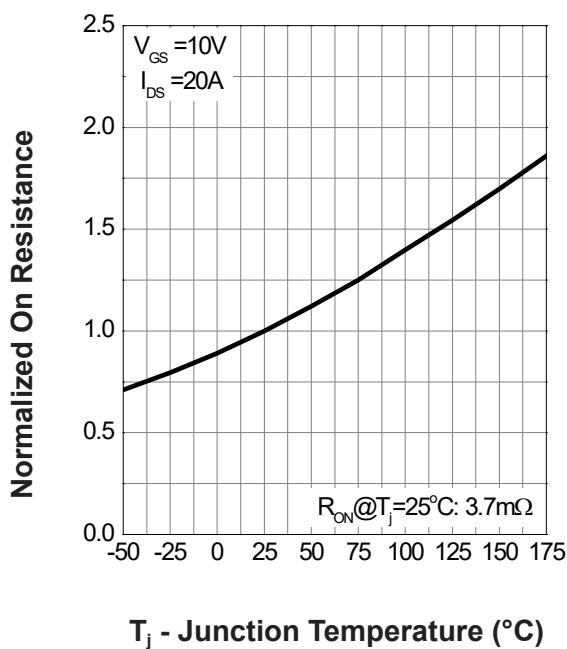
Capacitance



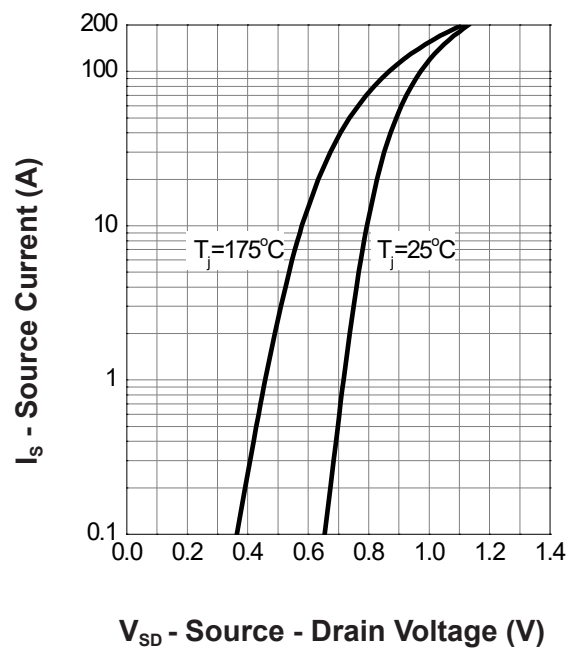
Gate Charge

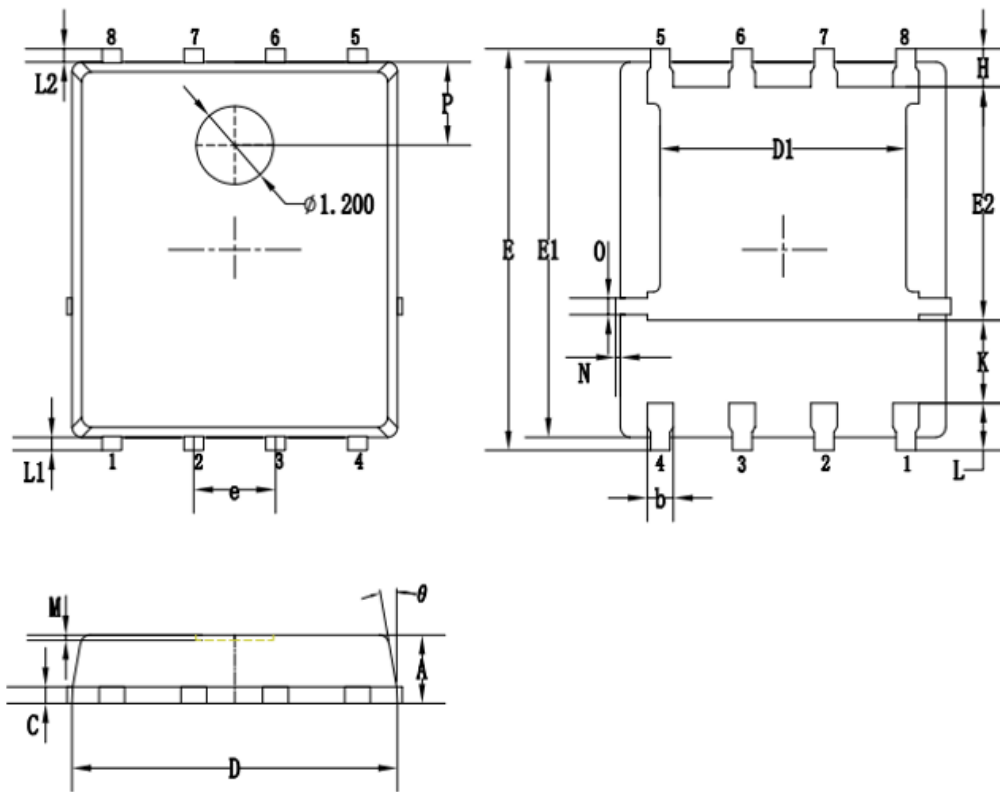


Drain-Source On Resistance



Source-Drain Diode Forward



Packaging information


SYMBOLS	MILLIMETERS		
	MIN.	NOM.	MAX.
A	0.90	1.05	1.20
b	0.35	0.40	0.50
C	0.20	0.25	0.35
D	4.90	5.05	5.20
D1	3.72	3.82	3.92
E	6.00	6.15	6.30
E1	5.60	5.75	5.90
E2	3.47	3.57	3.67
e	1.27 BSC.		
H	0.48	0.58	0.68
K	1.17	1.27	1.37
L	0.64	0.74	0.84
L1/L2	0.20 REF.		
θ	8°	10°	12°
M	0.08 REF.		
N	0	-	0.15
O	0.25 REF.		
P	1.28 REF.		

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